Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/780,286	·MIYAZAKI ET AL.
Examiner	Art Unit
Hal D. Wachsman	2857

	SEAR	CHED	
Class	Subclass	Date	Examiner
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702	121,184,124-126	5-28-05	n
324	212200,255	5-24-05	W
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7/4	727, 733	5-24-05	<i>m</i>
7/4	734,740	5.7005	fr
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DATE 19-D -28-D -28-D	la
-2400	la
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